


<b>Search Notes</b>  	<b>Application/Control No.</b>  10668973	<b>Applicant(s)/Patent Under Reexamination</b>  YANO ET AL.
	<b>Examiner</b>  Ahn, Sangwoo	<b>Art Unit</b>  2166

SEARCHED			
Class	Subclass	Date	Examiner
			SW

SEARCH NOTES		
Search Notes	Date	Examiner
EAST updated (see search history printout(s))	1/31/2008	SA
EAST updated (see search history printout(s))	8/12/2008	SA

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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